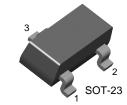


November 2006

MMBT4401K

NPN Epitaxial Silicon Transistor

Switching Transistor





1. Base 2. Emitter 3. Collector

Absolute Maximum Ratings $T_a = 25$ °C unless otherwise noted

Symbol	Parameter	Value	Units	
V _{CBO}	Collector-Base Voltage	60	V	
V _{CEO}	Collector-Emitter Voltage 40 V		V	
V _{EBO}	Emitter-Base Voltage	6	V	
I _C	Collector Current	600	mA	
P _C	Collector Dissipation 350 mW		mW	
T _{J,} T _{STG}	Operating Junction and Storage Temperature Range -55 ~ 150 °C		°C	

Electrical Characteristics T_a =25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Max.	Units
BV _{CBO}	Collector-Base Breakdown Voltage	$I_C = 100 \mu A, I_E = 0$	60		V
BV _{CEO}	Collector-Emitter Breakdown Voltage *	I _C = 1.0mA, I _B = 0	40		V
BV _{EBO}	Emitter-Base Breakdown Voltage	$I_E = 100 \mu A, I_C = 0$	6		V
I _{BEV}	Base Cut-off Current	$V_{CE} = 35V, V_{EB} = 0.4V$		100	nA
I _{CEX}	Collector Cut-off Current	$V_{CE} = 35V, V_{EB} = 0.4V$		100	nA
h _{FE}	DC Current Gain *	$V_{CE} = 1V, I_{C} = 0.1 \text{mA}$ $V_{CE} = 1V, I_{C} = 1 \text{mA}$ $V_{CE} = 1V, I_{C} = 10 \text{mA}$ $V_{CE} = 1V, I_{C} = 150 \text{mA}$ $V_{CE} = 2V, I_{C} = 500 \text{mA}$	20 40 80 100 40	300	
V _{CE} (sat)	Collector-Emitter Saturation Voltage *	$I_C = 150 \text{mA}, I_B = 15 \text{mA}$ $I_C = 500 \text{mA}, I_B = 50 \text{mA}$		0.4 0.75	V V
V _{BE} (sat)	Base-Emitter Saturation Voltage *	I_C = 150mA, I_B = 15mA I_C = 500mA, I_B = 50mA	0.75	0.95 1.2	V V
f _T	Current Gain Bandwidth Product	I _C = 20mA, V _{CE} = 10V, f = 100MHz	250		MHz
C _{ob}	Output Capacitance	V _{CB} =5V, I _E =0, f=100KHz		6.5	pF
t _{ON}	Turn On Time	V _{CC} = 30V, V _{BE} = 2V I _C = 150mA, I _{B1} = 15mA		35	ns
t _{OFF}	Turn Off Time	$V_{CC} = 30V, I_C = 150mA$ $I_{B1} = I_{B2} = 15mA$		255	ns

^{*} Pulse Test: Pulse Width≤300μs, Duty Cycle≤2%

Typical Performance Characteristics

Figure 1. DC current Gain

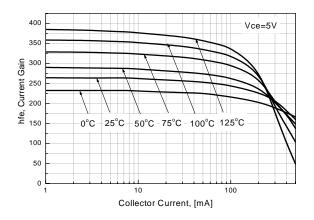


Figure 2. Collector-Emitter Saturation Voltage

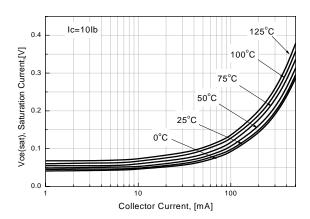


Figure 3. Base-Emitter Saturation Voltage

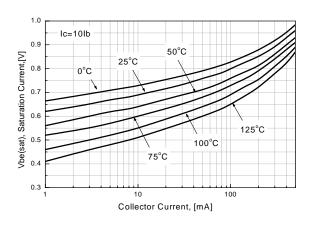


Figure 4. Collector - Base Leakage Current

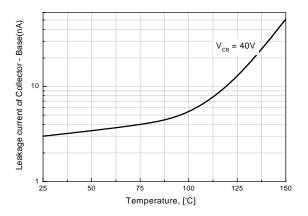


Figure 5. Collector-Base Capacitance

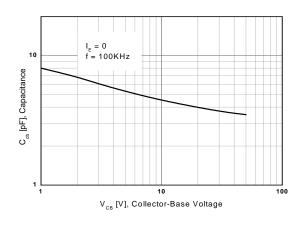
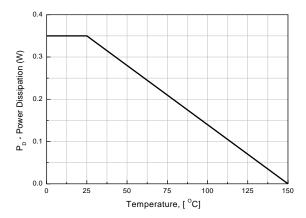
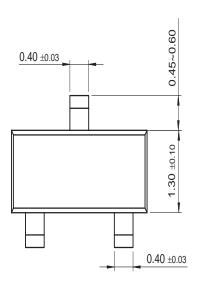


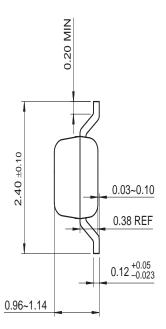
Figure 6. Power Dissipation vs
Ambient Temperature

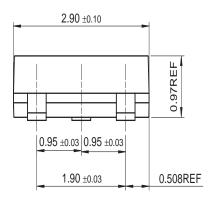


Mechanical Dimensions

SOT-23







Dimensions in Millimeters

UltraFET[®]

UniFET™

 VCX^{TM}

Wire™

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Rev. I20